imall

Chipsmall Limited consists of a professional team with an average of over 10 year of expertise in the distribution of electronic components. Based in Hongkong, we have already established firm and mutual-benefit business relationships with customers from, Europe, America and south Asia, supplying obsolete and hard-to-find components to meet their specific needs.

With the principle of "Quality Parts, Customers Priority, Honest Operation, and Considerate Service", our business mainly focus on the distribution of electronic components. Line cards we deal with include Microchip, ALPS, ROHM, Xilinx, Pulse, ON, Everlight and Freescale. Main products comprise IC, Modules, Potentiometer, IC Socket, Relay, Connector. Our parts cover such applications as commercial, industrial, and automotives areas.

We are looking forward to setting up business relationship with you and hope to provide you with the best service and solution. Let us make a better world for our industry!



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FAIRCHILD

SEMICONDUCTOR®

SGL40N150

General Description

Fairchild's Insulated Gate Bipolar Transistor (IGBT) provides low conduction and switching losses. The SGL40N150 is designed for induction heating applications.

Features

- High speed switching
- Low saturation voltage : $V_{CE(sat)} = 3.7 \text{ V} @ I_C = 40 \text{ A}$
- High input impedance

Applications

Home appliances, induction heaters, IH JAR, and microwave ovens.



Absolute Maximum Ratings $T_{C} = 25^{\circ}C$ unless otherwise noted

Symbol	Description		SGL40N150	Units
V _{CES}	Collector-Emitter Voltage		1500	V
V _{GES}	Gate-Emitter Voltage		± 25	V
I _C	Collector Current	@ T _C = 25°C	40	A
	Collector Current	@ T _C = 100°C	20	A
I _{CM (1)}	Pulsed Collector Current	-	120	A
PD	Maximum Power Dissipation	@ T _C = 25°C	200	W
	Maximum Power Dissipation	@ T _C = 100°C	80	W
Тј	Operating Junction Temperature		-55 to +150	°C
T _J T _{stg}	Storage Temperature Range		-55 to +150	°C
TL	Maximum Lead Temp. for Soldering Purposes, 1/8" from Case for 5 Seconds		300	°C

Notes :

(1) Repetitive rating : Pulse width limited by max. junction temperature

Thermal Characteristics

Symbol	Parameter	Тур.	Max.	Units
R _{0JC} (IGBT)	Thermal Resistance, Junction-to-Case		0.625	°C/W
$R_{\theta JA}$	Thermal Resistance, Junction-to-Ambient		25	°C/W

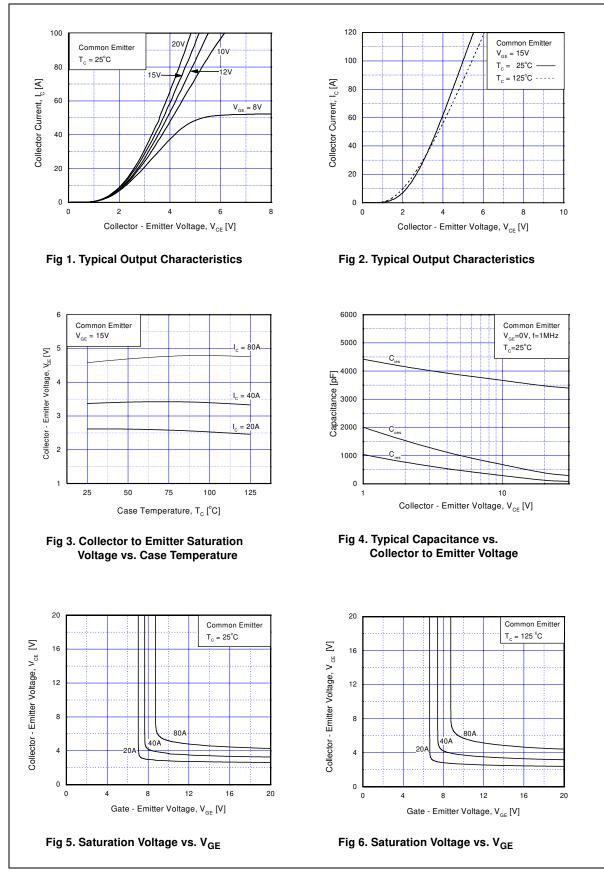
SGL40N150

IGBT

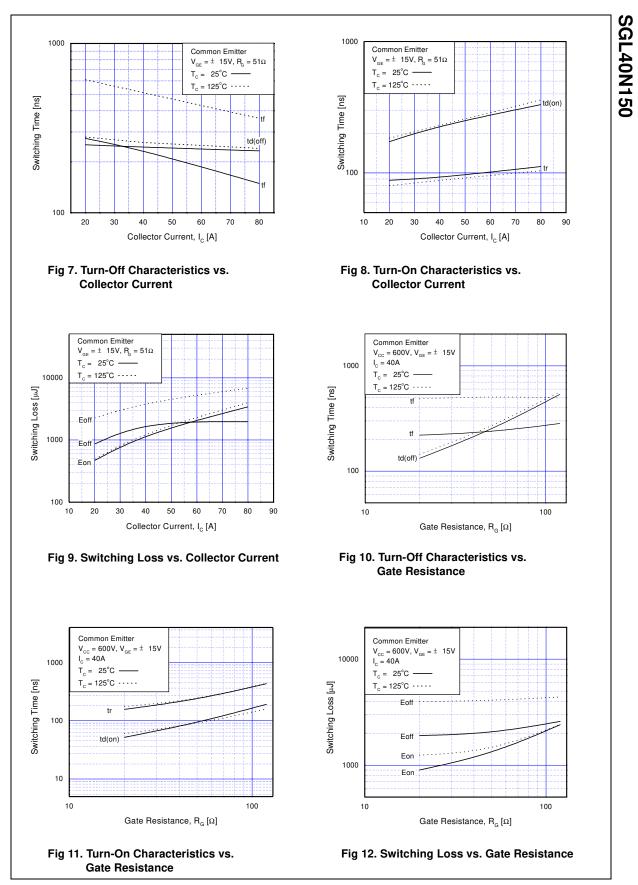
Symbol	Parameter	Test Conditions	Min.	Тур.	Max.	Units
Off Cha	racteristics					
BV _{CES}	Collector-Emitter Breakdown Voltage	V _{GE} = 0V, I _C = 250uA	1500			V
ICES	Collector Cut-Off Current	$V_{CE} = V_{CES}, V_{GE} = 0V$			250	uA
I _{GES}	G-E Leakage Current	$V_{GE} = V_{GES}, V_{CE} = 0V$			± 100	nA
On Cha	racteristics					
V _{GE(th)}	G-E Threshold Voltage	$I_{C} = 40 \text{mA}, V_{CE} = V_{GE}$	3.5	5.0	7.5	V
	Collector to Emitter					
V _{CE(sat)}	Saturation Voltage	$I_{C} = 40A, V_{GE} = 15V$		3.7	4.7	V
Dynami	c Characteristics					
C _{ies}	Input Capacitance			4000		pF
C _{oes}	Output Capacitance	$V_{CE} = 10V_{,}V_{GE} = 0V_{,}$		700		pF
C _{res}	Reverse Transfer Capacitance	f = 1MHz		300		pF
Switchi		$V_{aa} = 600 V_{aa} = 40 A_{aa}$	1	90		ns
t _{d(on)}	Turn-On Delay Time	$V_{00} = 600V I_0 = 40A$			200	
t _{d(on)} t _r	Turn-On Delay Time Rise Time	$V_{CC} = 600V, I_C = 40A,$ $R_G = 51\Omega, V_{CE} = 15V,$		230	700	ns
t _{d(on)} t _r t _{d(off)}	Turn-On Delay Time Rise Time Turn-Off Delay Time	$V_{CC} = 600V, I_C = 40A,$ $R_G = 51\Omega, V_{GE} = 15V,$ Resistive Load, $T_C = 25^{\circ}C$		230 245	700 400	ns ns
t _{d(on)} t _r t _{d(off)} t _f	Turn-On Delay Time Rise Time Turn-Off Delay Time Fall Time	– R _G = 51Ω, V _{GE} = 15V,		230 245 230	700 400 400	ns ns ns
t _{d(on)} t _r t _{d(off)} t _f Q _g	Turn-On Delay Time Rise Time Turn-Off Delay Time Fall Time Total Gate Charge	$R_{G} = 51\Omega, V_{GE} = 15V,$ Resistive Load, $T_{C} = 25^{\circ}C$		230 245 230 140	700 400 400 170	ns ns nS nC
Switchin t _{d(on)} t _r t _{d(off)} t _f Q _g Q _{gc}	Turn-On Delay Time Rise Time Turn-Off Delay Time Fall Time	– R _G = 51Ω, V _{GE} = 15V,		230 245 230	700 400 400	ns ns ns

SGL40N150

SGL40N150

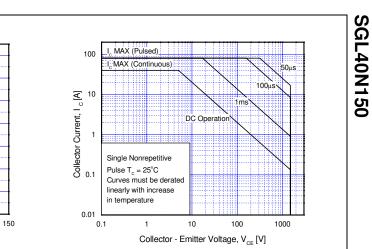


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SGL40N150 Rev. A1





Gate Charge, Qg [nC]

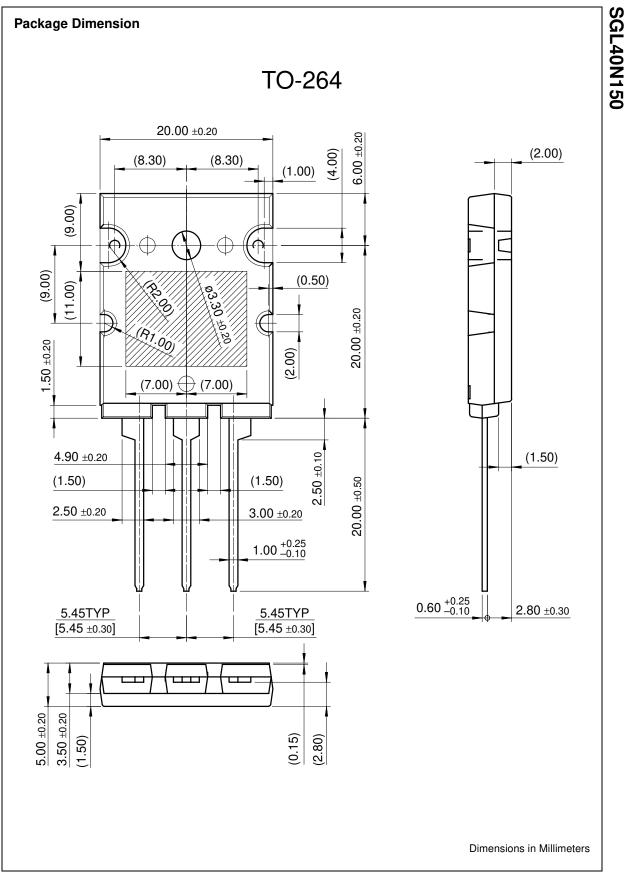
Common Emitter $R_{L} = 15\Omega, V_{CC} = 600V$

 $T_c = 25^{\circ}C$

Ò

Gate - Emitter Voltage, V_{GE} [V]





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Datasheet Identification	Product Status	Definition
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No Identification Needed	Full Production	This datasheet contains final specifications. Fairchild Semiconductor reserves the right to make changes at any time without notice in order to improve design.
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